CEP20N65S/CEB20N65S
CEF20N65S

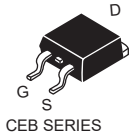
N-Channel Enhancement Mode Field Effect Transistor

PRELIMINARY

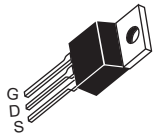
FEATURES

Type	V_{DSS}	$R_{DS(ON)}$	I_D	@V_{GS}
CEP20N65S	650V	0.18Ω	20A	10V
CEB20N65S	650V	0.18Ω	20A	10V
CEF20N65S	650V	0.18Ω	20A [d]	10V

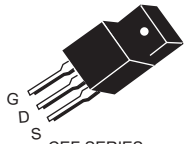
- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handing capability.
- RoHS compliant.



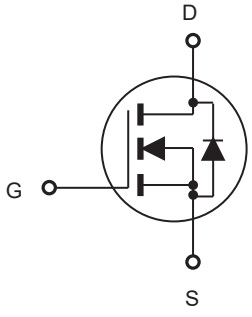
CEB SERIES
TO-263(DD-PAK)



CEP SERIES
TO-220



CEF SERIES
TO-220F



ABSOLUTE MAXIMUM RATINGS T_C = 25°C unless otherwise noted

Parameter	Symbol	Limit		Units
		TO-220/263	TO-220F	
Drain-Source Voltage	V_{DS}	650		V
Gate-Source Voltage	V_{GS}	±30		V
Drain Current-Continuous @ T_C = 25°C	I_D	20	20 [d]	A
@ T_C = 100°C		13	13 [d]	A
Drain Current-Pulsed [a]	I_{DM} [e]	80	80 [d]	A
Maximum Power Dissipation @ T_C = 25°C	P_D	205	35	W
- Derate above 25°C		1.64	0.28	W/°C
Single Pulsed Avalanche Energy [h]	E_{AS}	600		mJ
Single Pulsed Avalanche Current [h]	I_{AS}	5		A
Operating and Store Temperature Range	T_J,T_{stg}	-55 to 150		°C

Thermal Characteristics

Parameter	Symbol	Limit		Units
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.61	3.6	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	65	°C/W

This is preliminary information on a new product in development now .
Details are subject to change without notice .

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http://www.cet-mos.com

Electrical Characteristics T_C = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} = 0V, I_D = 250μA	650			V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 650V, V_{GS} = 0V			1	μA
Gate Body Leakage Current, Forward	I_{GSSF}	V_{GS} = 30V, V_{DS} = 0V			100	nA
Gate Body Leakage Current, Reverse	I_{GSSR}	V_{GS} = -30V, V_{DS} = 0V			-100	nA
On Characteristics [b]						
Gate Threshold Voltage	$V_{GS(th)}$	V_{GS} = V_{DS}, I_D = 250μA	2.5		4.5	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	V_{GS} = 10V, I_D = 10A		0.15	0.18	Ω
Dynamic Characteristics [c]						
Input Capacitance	C_{iss}	V_{DS} = 30V, V_{GS} = 0V, f = 1.0 MHz		1475		pF
Output Capacitance	C_{oss}			635		pF
Reverse Transfer Capacitance	C_{rss}			20		pF
Switching Characteristics [c]						
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 520V, I_D = 10A, V_{GS} = 10V, R_{GEN} = 6Ω		31		ns
Turn-On Rise Time	t_r			13		ns
Turn-Off Delay Time	$t_{d(off)}$			65		ns
Turn-Off Fall Time	t_f			8		ns
Total Gate Charge	Q_g	V_{DS} = 520V, I_D = 10A, V_{GS} = 10V		35		nC
Gate-Source Charge	Q_{gs}			8		nC
Gate-Drain Charge	Q_{gd}			13		nC
Drain-Source Diode Characteristics and Maximun Ratings						
Drain-Source Diode Forward Current	I_S				20	A
Drain-Source Diode Forward Voltage [b]	V_{SD}	V_{GS} = 0V, I_S = 10A			1.2	V

Notes :
a.Repetitive Rating : Pulse width limited by maximum junction temperature .
b.Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2% .
c.Guaranteed by design, not subject to production testing.
d.Limited only by maximum temperature allowed .
e.Pulse width limited by safe operating area .
h.L = 48mH, I_{AS} =5A, V_{DD} = 60V, R_G = 25Ω, Starting T_J = 25°C.

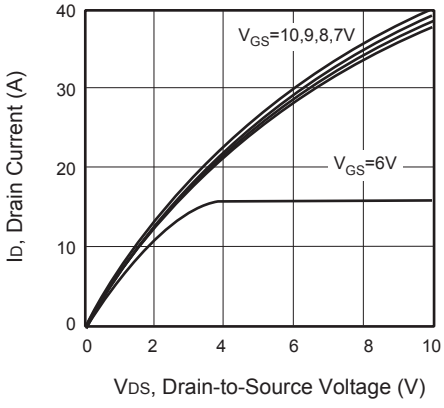

Figure 1. Output Characteristics

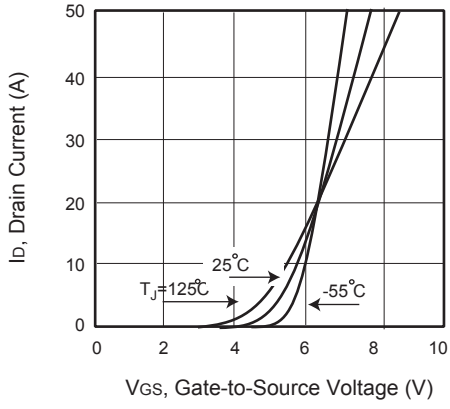

Figure 2. Transfer Characteristics

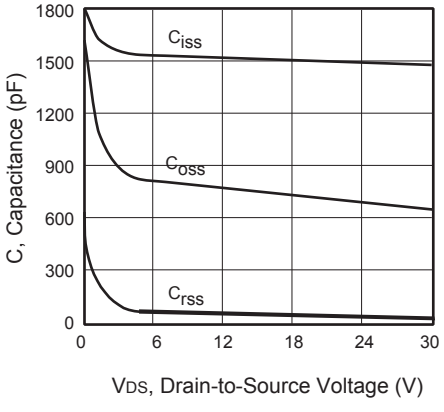

Figure 3. Capacitance

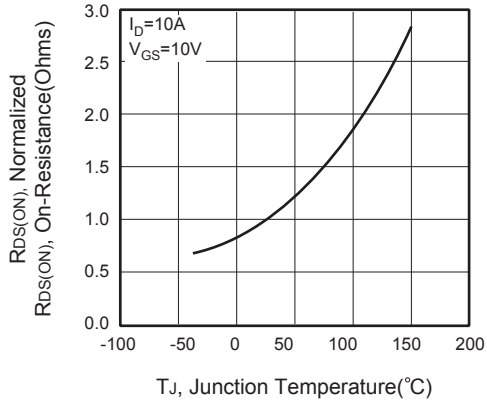

Figure 4. On-Resistance Variation with Temperature

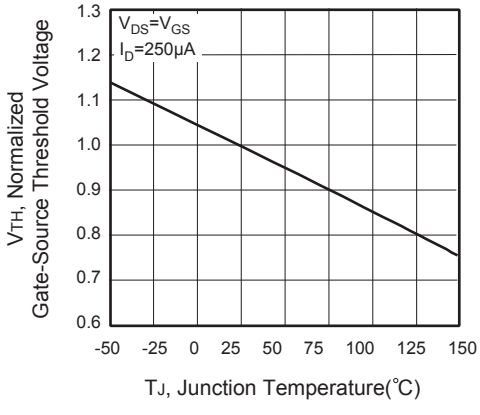

Figure 5. Gate Threshold Variation with Temperature

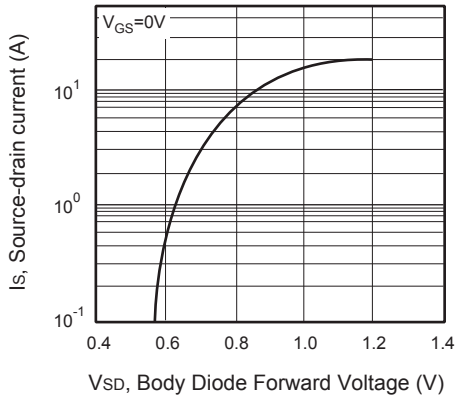

Figure 6. Body Diode Forward Voltage Variation with Source Current

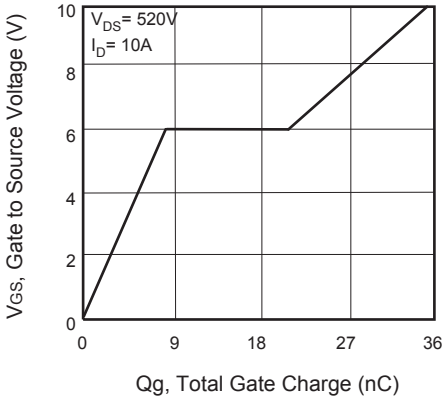

Figure 7. Gate Charge

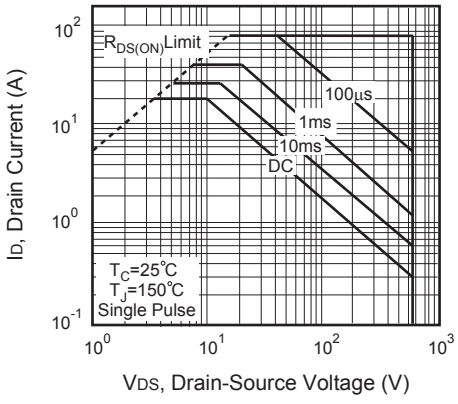

Figure 8. Maximum Safe Operating Area

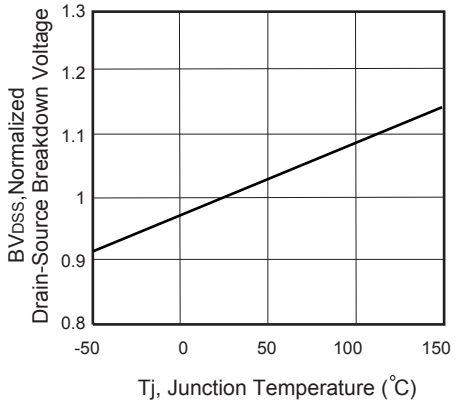

Figure 9. Breakdown Voltage Variation VS Temperature

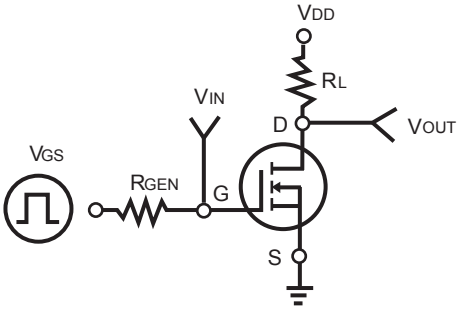

Figure 9. Switching Test Circuit

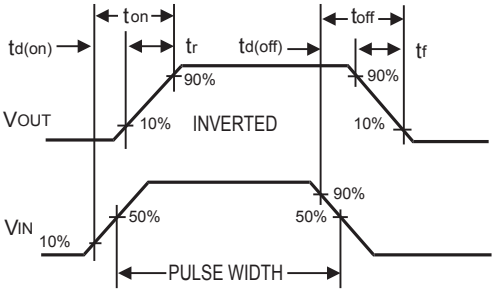

Figure 10. Switching Waveforms

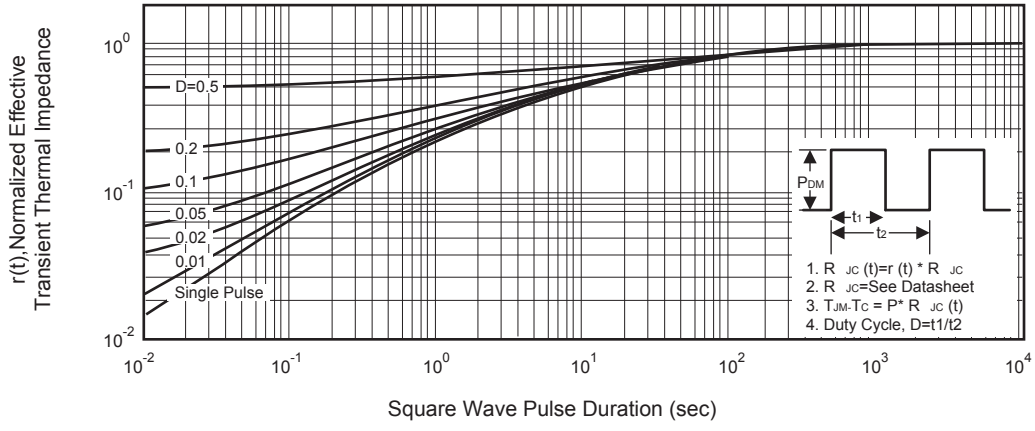

Figure 12. Normalized Thermal Transient Impedance Curve